

QUANTITATIVE CHARACTERIZATION of MICRO-TOPOGRAPHY — A BIBLIOGRAPHY of INDUSTRIAL SURFACE METROLOGY

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Provides 4800 literature citations on the quantification of micro- and nano-topographic surfaces and a brief introduction to the field of industrial surface metrology

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QUANTITATIVE CHARACTERIZATION of MICRO-TOPOGRAPHY

A BIBLIOGRAPHY of INDUSTRIAL SURFACE METROLOGY

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Abstract

A comprehensive bibliography of *surface metrology*, the numerical description and analysis of manufactured surfaces, improves access to research on topographic quantification that lies outside the usual Earth-science sources. A brief essay accompanying the 4800 literature citations introduces the field of industrial surface metrology to geomorphologists and other Earth scientists, describes similarities and differences between the two realms, and raises issues to be addressed in any attempt to unify the general practice of surface quantification. A sampling of Internet Web-site addresses and full abstracts on surface metrology supplements the main bibliography.

Introduction

This report makes available to digital-terrain modelers, geomorphologists, and other Earth scientists and engineers a new resource for the numerical description and analysis of topography. Rather than landscapes (Pike, 1993)¹, the attached bibliography of *surface metrology* addresses the quantification of manufactured surfaces. Although the micro- and nano-scale features described in the 4800 references listed here (Appendix I) include none of the terrain familiar to geologists, geographers, oceanographers, or civil and military engineers, students of the Earth will find in this listing much common ground with their industrial counterparts. In work on the microscopic terrains created by mechanical, physical, and chemical processes (Thomas, 1982a, 1999), engineers and scientists in manufacturing have long been contributing to *morphometry*, the generic discipline of shape quantification.

The Earth science most closely related to surface metrology is geomorphology, particularly its sub-specialties (for example, *terrain modeling*) that treat landscapes mathematically and statistically as continuous surfaces in the absence of (or despite) well-defined spatial structure (Moore and others, 1991; Pike, 1995a; Lane and others, 1998). Some manufacturing processes do yield spatial structure and miniature forms that can be delineated individually (Amar and Family, 1996; Medeiros-Ribeiro and others, 1998). Such surfaces may be more usefully analyzed by the quantitative approaches developed in geomorphology for drainage basins, volcanoes, sand dunes, meteorite-impact craters, and other landforms that are spatially discrete. A number of geologists and geophysicists have analyzed the random fine-scale roughness of fractured and faulted rock faces (Türk and others, 1987; Ameen, 1995; Brown, 1995), but the micro-quantification—increasingly by 3-D digital data—of machined or etched surfaces created by industrial procedures is unknown to most Earth scientists. The work referenced in Appendices I and II reveals that surface characterization by mechanical and optical engineers, and most recently high-technology manufacturers and materials scientists, has many parallels to the study of conventional landscapes.

¹ References in **bold type** are listed only at the close of this essay; all other citations are in the chronologically ordered Appendix I; those underscoring also have full abstracts in Appendix II.

Surface Metrology

Metrology is the practice of measurement for quality control in manufacturing. Its application to surfaces, known in industry as *surface metrology* or *surface topography*, arose from the need to quantify the roughness of metal surfaces, especially those in moving contact (for example, automotive piston rings and cylinder walls; Figures 1 and 2). The practice now embraces most other areas of manufacturing. The statistical morphology of micro-topography affects a great many industrial functions and products, ranging from paint adhesion to the performance of cosmetics and the precision of reflecting surfaces. The development of metrology has paralleled that of 20th Century science and engineering technology.

For a quick introduction to recent metrologic work in a variety of areas, see Appendices II and III. Thomas (1992) is a brief general overview. Whitehouse (1994), Stout (1994), and Thomas (1999) are major reviews that emphasize tribology—the study of friction, wear, and lubrication—particularly in mechanical engineering, metrology's earliest and best-known application. Hähner and Spencer (1998) is a non-technical introduction to tribology and its evolution as a field of applied physics. For an up-to-date review of surface roughness in tribology and contact mechanics, see Majumdar and Bhushan (1998). Thomas (1982a) is an older summary of metrology, and Russ (1994) deals specifically with fractal surface characteristics. Bhushan (1997) reviews some of the most recent developments of metrology and tribology, nanoscopic applications to magnetic tape and computer disk drives. Proceedings of an important conference on metrology and the properties of engineering surfaces were published last year (Rosén and Craford, 1997). (The next meeting in this series will be in the UK in April, 2000.)

Surface metrology is applied and practical. It arose well before World War II (Abbott and Firestone, 1933)² from the demands upon

mechanical engineers (together with development of the necessary precision instrumentation) to improve product quality by narrowing the tolerances of manufactured components. To do this it became necessary to quantify the wear on such moving parts as crankshafts and metal bearings and correlate measurements of surface roughness with the properties of lubricants, the composition of bearing alloys, and methods of surface finish (Thomas and Charlton, 1981). Metrology has long contributed to the development of national and international standards that employ surface measurements to control metal-finishing (ISO, 1996a, b). More recently, surface measurements have been correlated with manufacturing processes in which thin films of various elements and compounds are deposited on smooth substrates, and other applications in materials science and the semiconductor industry (Amar and Family, 1996; R.K. Singh and others, 1996). Maintaining reliable performance of magnetic storage devices and other hardware essential to the Information Age would be impossible without metrology (Bhushan, 1990, 1997).

Much of the work on surface metrology appears in *Wear*, *Industrial Metrology*, *Precision Engineering*, the *Journal of Computer-Assisted Microscopy*, and other specialized publications in engineering, as well as those in applied physics and chemistry. The optics literature is a particularly good example. Because unwarranted roughness on lenses and mirrors can degrade the performance of lasers and optical imaging systems, surface metrology has long been an essential practice in optical engineering (Bennett and Mattsson, 1989). The Society of Photo-optical Instrumentation Engineers (SPIE) and the American Society for Precision Engineering (ASPE) from time to time hold meetings partly or entirely devoted to surface metrology. Quantification of micro-surface roughness is increasingly encountered in biology and medicine. For instance, fine-scale measurement in chemical engineering is important in maintaining cleanliness and consequent biological sterility of fermentation vessels. In medicine, surface roughness affects the assimilation to the human body of surgical implants and prostheses of

² Appendix I does not record the origins of surface metrology. An extensive German literature on surface finish, including descriptions of some of

the earliest instruments, was reviewed by Schmaltz (1936).

various kinds. Wennerberg's (1996) review of the effects of roughness on the performance of implants, for example, contains over 200 references (see also Wennerberg and others, 1996).

The sophistication of industrial practice in measuring the fine-scale roughness of surfaces has increased steadily with improvements in instrumentation. Metrologic techniques since World War II have advanced from central-tendency and dispersion statistics of surface-topographic profiles of metal bearings (Posey, 1946; Myers, 1962), through the modeling of these two-dimensional samples as random, isotropic Gaussian fields using autocorrelation and spectral analysis (Sayles and Thomas, 1978b, c; Whitehouse and Phillips, 1978), to a major shift now underway. This latest change, the advent of digital 3-D imaging and micro-topographic mapping (Russ, 1994; Stout, 1994) of metal, semiconductor, and even organic surfaces (Mechaber and others, 1996), is revolutionizing metrology. Before this breakthrough, industrial surfaces were characterized by tracing a linear profile across a sample area with a micro-stylus instrument (Thomas, 1992). A long-standing disadvantage was the unidirectional character of the resulting sample, which could not capture surface anisotropy without resorting to multiple passes of the instrument. Also, resolution of such instruments was insufficient to address many industrial problems (Rosén and others, 1996).

Methodological limitations of the sampling profile (El-Soudani, 1978; Nowicki, 1985; Sherrington and Smith, 1987), to say nothing of inadequate resolving power, have been overcome by such precision devices as the scanning tunneling and atomic force microscopes (AFM) and optical interferometers (Wickramasinghe, 1989; Robinson and others, 1991). These instruments image and measure industrial surfaces at very fine resolution (**Amato, 1997**) and enable accurate topographic maps to be created down to the atomic scale (Appendix III). With the profile thus giving way to the surface as the preferred sampling design (Stout, 1994), all the powerful techniques of spatial analysis—many well known in the Earth sciences—have become available to micro- and nano-morphometry. Metrology has not hesitated to develop these techniques, independently of other fields, from work by such applied mathematicians as **Matheron (1965)**, **Mandelbrot (1967, 1975)**, and **Daubechies (1990)**.

Arguably, methods of 3-D analysis in surface metrology, among the first disciplines to apply fractal concepts (Berry, 1979; Pfeifer, 1984; Thomas and Thomas, 1986b) and wavelets (**Mallat, 1989**; Wolf and Husson, 1993; Shibutani and Kitagawa, 1995; Lee and others, 1997) to surface characterization, now rival those of Earth scientists in their sophistication (Russ, 1993, 1994; Dong and others, 1994a, b; Amar and Family, 1996).

The Thomas Bibliography

The 4800 literature citations presented here (Appendix I) trace the evolution of surface metrology over some 70 years. (The technical disciplines employing metrology date back much further; Hähner and Spencer, 1998). All but a hundred or so of these references were compiled by the second author, a senior engineer in industrial surface metrology in the U.K., who may be best known to Earth scientists for a 1978 Nature article, "Surface topography as a nonstationary random process", co-authored with Richard Sayles. His 1982 book Rough Surfaces, the second edition of which is scheduled for release in early 1999 (<http://www.wspc.com.sg/books/engineering/p086.html>), has been a standard reference in the field. (A list of 650 references appeared earlier; Thomas and King, 1977). A bibliography of surface metrology by Thomas that is current through 1995 and contains full abstracts is available commercially on CD-ROM from the Swedish firm Toponova AB, (toponova@algonet.se).

Appendix I, which samples but a fraction of the published work in metrology, is the largest bibliography on surface roughness available in the open literature. The listing comprises all of the Thomas CD-ROM citations (less their abstracts), a partial 1996 update by Thomas, some 1997-98 entries added by Pike, and a number of older citations (also added by Pike) not in the original Thomas lists. The bibliography is not cast in standard USGS style and the entries differ in format and completeness (for example, in the use of abbreviations), reflecting the listing's long evolution and non-USGS origin. Random changes during conversion of the computer file from its

original format altered some references, and occasional missing or added text characters and spaces will be encountered, along with a number of misspelled author names. Many more of these irregularities were repaired in editing the list for this report, and some 500 duplicate entries were removed. Appendix II is a 1996 subset of the Thomas bibliography. It contains 36 complete abstracts that offer details of recent work in surface metrology, much of which deals explicitly with fractals and other surface measures of current interest to Earth scientists. Appendix III, a dozen Internet Web sites devoted to metrologic topics, supplements the print citations with instant, if still-rudimentary, access to the field.

Appendix I differs from bibliographies compiled originally by the second author in one important respect. We have recast it chronologically, retaining alphabetical order only within one-year brackets. One reason for this change is historical. Earth scientists and others unfamiliar with industrial surface metrology can trace its conceptual and technical development from the 1930's³ and compare this evolution with that of surface quantification in their own specialties. Students of metrology will find this helpful as well. Second, the rapid increase in research activity is made more evident. Entries for 1995, the last year that approaches completeness, alone comprise 20% of the listing. Also, industrial morphometry is diversifying from mechanical engineering, once the dominant application of surface-roughness measurement, into semiconductors and other high-technology materials. The chronological order not only documents this change but also helps group information on the newest specialties apart from earlier, more traditional, work in metrology without our having to rearrange the entire bibliography topically—an undertaking not possible at this time. Finally, up-to-date work in various subfields of surface metrology (through, say, 1996) can be found fairly rapidly by browsing only the most recent years, and without having to know the name of an author.

The subject matter of the attached listing is quite diverse, and we do not review it here. Nor did we cull it to include just those works most likely to

appeal to Earth scientists, at best a dubious exercise in subjectivity. Rather, we believe all 4800 citations make an important statement: that Earth science is not the only field in which surface-form representation is of such central importance—in volume and variety industrial surface metrology now dwarfs the practice of morphometry in geomorphology. Much material in Appendix I will seem exotic to geomorphologists and their colleagues in geology and physical geography. The bulk of the references, particularly those to atomic-scale surfaces in such serials as *Surface Science*, do not relate directly to the DEM-based 3-D measurement of topography. However, amid such unfamiliar terms as "molecular-beam epitaxy" and "photobleaching in side chain NLO-polymers," terrain modelers will glean information and concepts that touch upon their own work. This exchange works in both directions. The increasingly common references in Appendix I to Earth-science topics, mostly engineering applications in hydrology and remote sensing, emphasizing terrain roughness show that industrial metrologists, too, are venturing outside their field for new ideas to solve problems in surface characterization (Schloss, 1966; Manninen, 1992; Govindaraju and Kavvas, 1994; Claussen, 1995; Premus and Alexandrou, 1995).

Discussion—a Convergence of Disciplines

The need for terrain modelers and metrologists alike to analyze surface form links the Earth sciences with industry in a common endeavor that exemplifies the growing integration of much modern science and technology (Mandelbrot, 1975; Bak, 1996; Wilson, 1998a). Here, in publishing a bibliography of surface metrology, we examine a few implications of this convergence and the prognosis for a unified practice of surface quantification.

What makes the convergence possible is an operational definition by which both Earth science and industry find it convenient to define most surfaces: within a specified scale of interest, a surface is broadly planar but irregular in detail. By this convention, all surfaces regardless of scale have a similar gross geometry

³ See footnote 2.

comprising two long (spatial) dimensions and one short one (relief). Consequently all surface irregularities can be measured in Cartesian coordinates, (X,Y) in the spatial domain defined by the overall-planar trend of the surface and (Z) in the relief domain normal to that trend. This simple convention is important, because it distinguishes nominally two-dimensional, continuous surfaces from those of three-dimensional objects—plants and animals, sedimentary particles, and mineral grains—which are better quantified by such morphometric approaches as landmark analysis (Bookstein, 1995; Marcus and others, 1996). Formally, the characterization of any continuous surface as defined here is grounded in the unifying concept of the *spatial random field*, which in turn is based on mathematical set-theory and probability (Adler, 1981; Christakos, 1992).

We restrict the discussion here to *single-valued* surfaces, those for which all values of (X,Y) have only one value of (Z) . This condition does not hold for convoluted surfaces, where contour lines depicting such re-entrant features as overhangs and cavities "disappear" beneath contours at higher elevations. Examples include much karst topography (landscape scale), a gravel river-bed or beach (finer scale), and soils (very fine scale). On a molecular scale, some industrial surfaces also are *multi-valued*; evidence from surface chemistry indicates that the area of absorption of a machined surface is many times its geometric area. However, the measurable surface—the *response* surface (Agullo and Pages-Fita, 1974) rather than the *true* surface—is necessarily single-valued with respect to height because the techniques of measurement and data reduction in metrology (and most Earth sciences) do not cope effectively with multiple values of height. It is because of this restriction that a fractal response-surface is self-affine rather than self-similar. Soil scientists, who must measure porosity and other internal characteristics of soil structure, have devised techniques—some of them adapted from stereology—to quantify multi-valued surfaces (Droogers and others, 1998; Horgan, 1998). Such complex surfaces, where X , Y , and Z all may assume values of equal magnitude, differ qualitatively from "surface" as defined here.

The task of characterizing single-valued surfaces in three dimensions reduces to a problem in

descriptive geometry and topology, referenced to a relief datum, Z_0 . The Z_0 -datum convention—mean sea level for Earth, arbitrarily determined elevations or levels on both other planets and on surfaces formed by industrial processes—can be applied to the relief forms on any surface, whatever its scale or the processes that formed it. The peaks, depressions, valleys, ridges, and other surface features thus observed in 3-D space are characterized numerically by various measures in profile (Z) and plan (X,Y). These measures are equally germane to solving practical problems on the shop floor and in the Earth sciences. The cross-hatched topography of honed scratches on a machined cylinder-wall, for example, is as rich in relief content, and as capable of measurement and analysis, to a mechanical engineer as the terrain defining the drainage pattern of a fluvial system is to a geomorphologist.

Some Similarities

In practice, terrain modeling and surface metrology have much in common. Above all, understanding the links between a surface and the process(es) shaping it is equally important in industry and the Earth sciences. That the specific processes themselves and the motivations for understanding them may differ in scale or kind do not diminish this similarity. As in geomorphology, moreover, the two overarching agents that shape the irregularities on all industrial surfaces are erosion (Rosén and others, 1996) and deposition (Medeiros-Ribeiro and others, 1998) acting on broader surfaces formed by other means—for example, a tectonic event in the case of geology, a metal casting or laboratory-grown silicon wafer in industry. Material is removed from or added to a surface, or otherwise redistributed, in various ways. Erosion or deposition may figure in the shaping and finishing of a manufactured surface as well as in changes that take place throughout its service life as a component of a more complex device. Erosion of industrial surfaces occurs by processes that have coarser-scale counterparts in the Earth sciences. Among these are brittle and ductile failure of materials under directed stress, chemical etching (Boland and Weaver, 1998) and decomposition, change of state (melting), and

various types of abrasion—commonly in the presence of a lubricant or other fluid. Certain industrial finishing processes, such as peening and roller burnishing, neither remove nor add to existing material. Instead they redistribute it by plastically deforming higher regions of the surface so that material flows into lower regions—a rearrangement of mass that has parallels in both geophysics and geomorphology. Surfaces formed by some processes in both fields are thought to exhibit such recently identified characteristics as fractal geometry, chaos, and self-organized criticality (Mandelbrot, 1975; Bak, 1996).

Many of the operational issues that arise in assessing form:process links in the two realms are identical. First, all surface descriptions save that of a perfect plane (the only scale-independent surface) are inexact and incomplete. Because no amount of information can capture all attributes of a surface, the abstraction of its form is always a compromise. The usual practice is to take a sampling of measurements over some representative area. To do this both Earth science and industry rely increasingly on square-grid arrays (now supplanting linear traverses or profiles) of surface heights, or digital elevation models (DEMs; also DTMs, digital terrain models). Resolution of the gridded data, the (X,Y) distance between heights—commonly constrained by prevailing technology, determines the precision of results from subsequent analysis. In analyzing these measurements, similar approaches to capturing the many attributes of surface form—together with the computer algorithms to express them, are employed by both disciplines. The specific techniques are grounded in descriptive geometry, statistics, and topology. They include such basic tools of morphometry as elevation-frequency, analysis of peak elevations and closed depressions, expression in plan and profile of the angles of slope and slope curvature, the distribution of slope aspect or azimuth, spatial autocorrelation and power-spectral-density analysis, division of a surface into areas of similar form, calculation of fractal dimensions, and assessing relief:distance properties by geostatistical (semi-variogram or structure-function; Wald, 1989) modeling.

Similar technical problems in surface analysis are common to both Earth science and industry. These include improving data quality through

new instrumentation and more precise techniques of measurement, characterizing nonstationary (anisotropic, or spatially inhomogeneous) surfaces, an irksome "parameter rash" of untested or incompatible measures (compare the criticism by geomorphologist Evans, 1972, with those of engineers Thomas, 1981, and Whitehouse, 1982a), parameter correlation and redundancy (Gorlenko, 1981; Nowicki, 1985), quantifying surface texture by spatial (topologic) descriptors [geomorphologists who only recently rediscovered Maxwell's 1870 paper "On hills and dales" (Mark and Warntz, 1982) will enjoy reading of engineer Paul Scott's (1997) similar epiphany], evaluating the scale-dependence of surface form, devising numerical "signatures" or "fingerprints" to characterize surfaces created by known processes (Pike, 1995a), equifinality—the vexing problem of similarly shaped surfaces formed by different processes, and developing more effective ways to visualize surface complexity.

One of the most enduring gifts of the computer revolution, exploited alike by the Earth sciences and industry, is machine visualization—the calculation of synthetic surfaces (both the very large and the very small) that are otherwise invisible to the unaided eye. Although here we emphasize the numerical description, or parameterization, of surfaces, we point out that computer visualization is the perceptual component of morphometry: 3-D images of natural terrain and manufactured surfaces are computed from the same digital height data required for descriptive statistics. The two most common types of resulting graphics for surfaces are the wireframe ("fish-net") plot and the rather more aesthetic shaded-relief image. Whereas Earth scientists commonly compute relief-shaded topography for areas too large or remote to be viewed in the field (Pike, 1992), metrologists create images to better interpret surfaces too small to be viewed with the unaided eye. Important discoveries can result. For example, by comparing wireframe plots from high-resolution AFM data, Rosén and others (1996) found that the observed height-distribution resulting from wear in one area of an automotive-engine cylinder differed dramatically from what had been predicted by the prevailing tribological model (Figure 2). Descriptive statistics, which also revealed the

cylinder-bore surfaces to be multifractal, agreed with the visual results.

Industry and the Earth sciences converge most closely via metrology and terrain modeling, respectively, in the quantification of surface roughness *per se*. Although roughness measurement is the very point of much of metrology, before advent of the digital computer it was but a minor activity in geology, geography, geophysics, and civil and military engineering (Goldberg, 1962). With proliferation of such computer-intensive techniques as spectral and fractal analysis, the quantification of relief "roughness" in continuous terrain (in contradistinction to discrete "landforms") has become routine. Among the earliest applications were line-of-sight evaluation for military operations (Wood, 1961), measurement of aircraft-runway and highway roughness (Houbolt, 1961), and evaluation of cross-country trafficability by vehicles (Bekker, 1969). Quantitative knowledge of the Moon's surface roughness was essential to success of the Apollo program (Schloss, 1966; Rozema, 1969). More recently, surface roughness has been measured to determine acoustic-scattering properties of Earth's polar sea-ice (Rothrock and Thorndike, 1980) and seafloor (Fox and Hayes, 1985), to model the effect of broad-scale terrain on weather conditions (Daly and others, 1994), and, at the micro-scale, to quantify the effect of fracture surfaces on the flow of fluid through rocks (Glover and others, 1998). Related work has quantified the roughness of natural stream channels (Nikora and others, 1998), agricultural fields (Römken and Wang, 1986), complex terrain surrounding turbines (windmills) that harvest wind energy for generating electric power (Mortensen and Petersen, 1997), and topography that is vulnerable to debris-flow landslides (Ellen and others, 1997).

Some Differences

The overlap of Earth science and manufacturing described here does not diminish differences in their treatment of surface form. First among these is process. Because most agents of erosion and deposition and their resulting surface forms contrast sharply in the two fields, the likelihood

of much "interlocking of causal explanations across disciplines" (Wilson, 1998a) is remote at this time. For example, the varied responses of air masses to topography as they pass over different mountain ranges are not governed by the same physical principles that control, say, the varied interactions of crankshaft journals and their enclosing bearings in response to different lubricants and techniques of metal finish. The prime difference is absence of fluvial erosion and deposition in manufacturing; no miniature rivers are carving meanders in silicon wafers. Other gravity-driven agents, such as slope-failure, also are absent from industrial procedures. However, chemical solution and etching are common to both geomorphology and industry, as is abrasion, both by direct contact (glacial erosion; grinding and honing) and by wind-driven particles (eolian erosion; grit-blasting and milling by water-jet technology). Given the rapid progress of ongoing research in both fields, we caution against too-hasty dismissal of the possibility of some convergence in the nature of fundamental surface-forming processes.

Another contrast lies in the spatial structure of surfaces addressed by the two disciplines. Much of the Earth's topography comprises integrated, hierarchical networks of discrete, nested drainage basins that are well defined. Nonfluvial landforms that also can be delimited areally (among them volcanoes and sand dunes) are recognized on Earth's surface, on its seafloor, and on surfaces of other planets. Industrial processes and contact mechanics tend to create continuous surfaces that have less systematic spatial structure. Many techniques of fabrication and mechanisms of wear do impart distinctive surface textures, but these commonly are repeating patterns; discrete microscopic "landforms" (Aguilar and others, 1992c; Amar and Family, 1996) are rare. The rank-and-file orderliness of atoms and molecules deposited on silicon wafers and other substrates (Amato, 1997) has no clear analogs in geomorphology. We predict the contrast in surface structure will diminish. As the techniques of high-technology progress and further discoveries are made in the microscopic properties of materials surfaces, more spatial structure will be identified in industrial applications (Lee and others, 1998).

An obvious if less fundamental difference, also related to process, is scale: landforms are orders

of magnitude larger than the micro- and nano-scopic irregularities on machined surfaces or magnetic tape. Similarity in format of the digital height data required for analysis in both cases pales beside the contrast in scale of the surface features they are intended to capture. Both disciplines now obtain matrices of surface elevations automatically from sophisticated equipment, but Earth scientists image km-wide swaths of terrain from aircraft or satellites whereas the metrologists' laboratory instruments measure samples as small as 100 microns across. The resolution of DEMs for geomorphic work ranges from mm in studies of tilled fields to tens, even hundreds, of km in tectonic modeling; analysis of industrial surfaces requires DEM resolutions of millionths to billionths of a millimeter. We believe that this contrast, however dramatic, is not very important and will become less so as sub-visual surface forms and processes become better understood.

The disparity in scale has at least one important consequence—unlike Earth science, surface metrology remains restricted to small samples. It is not yet feasible to obtain continuous 3-D data for a large workpiece, such as the entire top-to-bottom extent of an automotive cylinder, in one pass of a device that images at micro- to nano-meter resolution. High-precision instruments are still too limited in their range of travel. Nor is it feasible, as it is in digital-cartographic applications in the Earth sciences, to achieve continuous large-area coverage by joining together many smaller map quadrangles. The reason for this lies in the way metrological elevations are usually referred—not to a common datum on the measured surface, but to an arbitrary instrument datum that is effectively reset for each new measurement. Scanning laser-interferometers now can stitch smaller samples together into a larger area using pattern-recognition algorithms. However, until such problems as erroneous elevations at sample-area boundaries are solved, the technique remains experimental and the samples small.

Metrology and the Earth sciences deal differently with similar operational problems. An important example is measuring the effects through time of the surface-shaping agents. Geomorphologists like to observe a landscape repeatedly, over the long term, to learn how topography evolves under the prevailing set of

processes. This is possible for sand dunes and other ephemeral landforms (Norris, 1966). It is also comparatively easy to reoccupy a survey site to take new data. However, most landscapes change so slowly that effects measurable even over the lifetime of the observer may be minor. To get around this difficulty, samples in space may be substituted for those in time. Under this assumption, the *ergodic* hypothesis, measurements are taken on several coeval, preferably neighboring, landscapes that appear to show evolutionary, sequential, development under the same regime (Chorley and others, 1984, pp. 32-33, 328-330). This expedient must be applied with caution when interpreting the morphometry of a set of samples to formulate models of landscape evolution.

Unlike geomorphologists, metrologists would appear to have unrestricted access to topography that reflects time-dependent effects of surfacing processes, thus clearly linking form with function. Examining "before" and "after" results from wear tests on such parts as automotive bearings and engine cylinders has long been common practice in the laboratory and on the shop floor. However, there is a problem in making quantitative 3-D, not just visual, observations on the components—measuring exactly the same surface before, sometimes during, and after a test run. Because the instrumentation required to obtain fine-scale data is of such high resolution, it is difficult to physically relocate the sample with the precision required to obtain sequential data for the identical sample space. Index marks on the workpiece are too crude for the micro- and nano-precision required to reposition atomic-force microscopes and other devices. Although an experiment can be run on several identical components, each one being measured at a different stage in the test—in analogy with *ergodic* sampling of landscapes, *strictu sensu* the same micro-surface is not being followed throughout the course of its evolution.

A final difference, that of the objectives of morphometric analysis, mirrors some of the basic cultural differences between science and engineering. Partly this reflects the commercial goals toward which much metrologic work is directed. Metrology is vital to the invention of new products, the most dramatic example being those from the semiconductor industry. Metrologists have long measured manufactured

objects to quantify surface irregularities that degrade a product's function and shorten its service life. They wish to achieve predictability of product, improve such industrial properties as the adhesion of paint to metal surfaces, understand the interactions between machined components in moving contact, and control quality in the fabricating process by following industry standards⁴. Earth scientists, particularly geomorphologists, measure topography formed by natural processes. They seek to mitigate natural hazards, assess water and soil resources, probe landscape/climate links, and understand the sequential development of topography in space and time. In related work, oriented less toward interpretation of process and thus perhaps more closely aligned with the objectives of metrology, civil and military engineers quantify terrain to plan transportation and communications facilities, land and maneuver spacecraft, or optimize weapons deployment.

Given such disparate objectives and disciplinary cultures, scientists and engineers working with natural topography thus far have had little occasion to meet professionally with their opposites in industry. Only rarely do results from one discipline appear in publications by the other. Recent exceptions, including the 1996 report by Cardenas-Garcia and Severson and the 1997 paper by Paul Scott, suggest that this trend may be changing.

Conclusions

Any convergence, however tentative, of manufacturing and Earth science through the quantification of surface form offers an opportunity to exploit the above similarities and explore—perhaps to reconcile—some of the differences in an effort to develop a more unified discipline of surface representation. The bibliography appended here is one step toward this goal. Comparable references lists on terrain modeling in the Earth sciences, now available to

⁴ Manufacturing tolerances have been narrowing by a factor of three each decade for the last 30 years (Kind and Quinn, 1998).

the metrology community, constitute another such step (Pike, 1993, 1995b, 1996⁵).

Topics in common that remain to be studied range widely, from the nature of physical and chemical surface-forming processes, through sampling designs and parameter choices, to manipulation and interpretation of descriptive measures. Metrologists have much to glean from Earth science's longer experience with surface quantification, particularly post-World War II work on continuous terrain by civil and military engineers and oceanographers. Geographic information systems (GIS) technology, with its wealth of analytic tools for manipulating and visualizing raster DEMs, is an underutilized resource that deserves to become more routine in metrology. Conversely, industry and the vast research enterprise supporting it are actively advancing surface morphometry in directions that converge with the objectives of terrain modelers. Earth scientists are not alone in trying to understand the self-similar and multi-fractal properties they observe in topography. Geomorphologists and hydrologists would do well to follow the efforts of industry engineers and scientists who also are interpreting fractal configurations and probing questions of self-organization, albeit in the fine-scale landscapes of computer storage-devices, automotive sheet-metal, and human skin.

This report directs Earth scientists toward industry's experience in the quantitative representation of surfaces. We hope that the two communities will discover in one other concepts and methods that can be applied to advance knowledge in their own areas. The importance of surface form in high-technology manufacturing, particularly in such heavily supported areas as semiconductors and advanced materials, assures that metrology will continue to develop fresh ideas, some of which may adapt to characterization of the land surface by Earth scientists. We believe that such cross-fertilization is worth exploring, even if the goal of a unified field of surface-form quantification is not immediately forthcoming. If the course of science and technology in the 20th Century has taught us one thing, it is to expect the unexpected:

⁵ The fourth report in this series has been prepared; it will be released early in 1999.

particularly in today's interdisciplinary, globalized research environment, new knowledge can emerge from any quarter. Or, again after **Wilson (1998b)**, "There is no fixed way to make and establish a scientific discovery. Throw everything you can at the subject ..."

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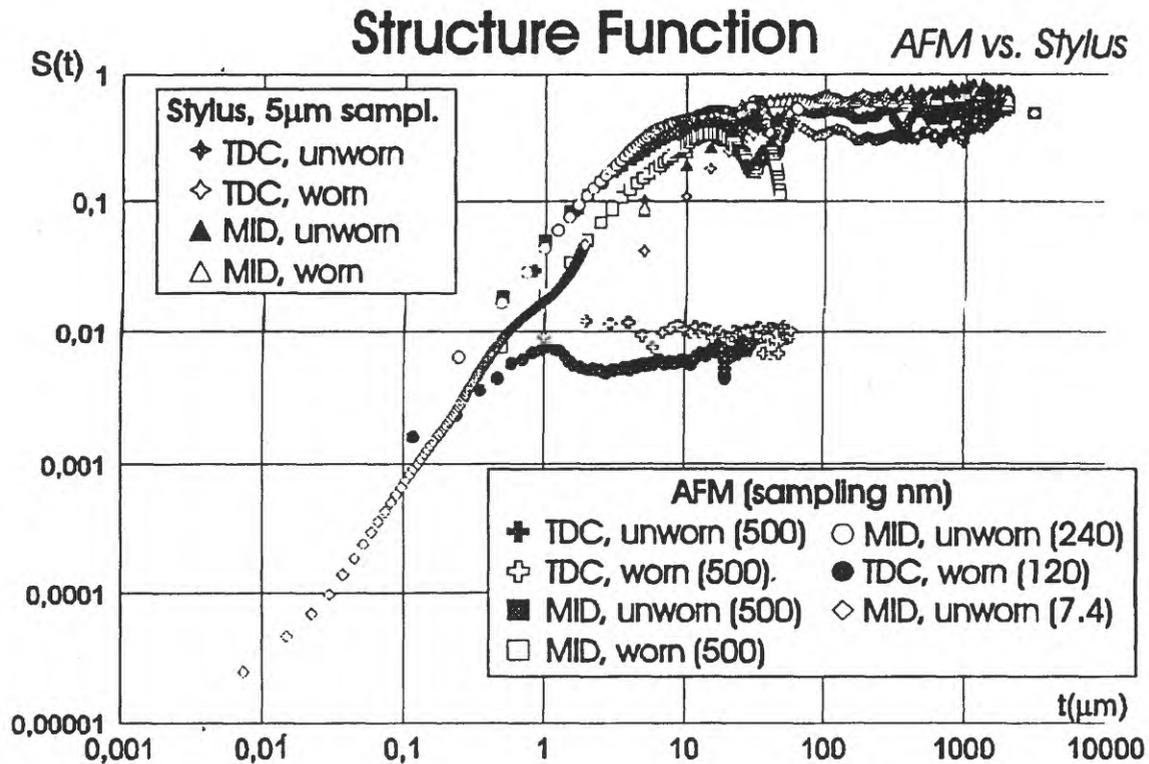


Figure 1. Example of parametric analysis of 3-D surface-metrology height data. Graph shows scale dependence in the surface roughness of a honed cylinder bore of an automobile engine, for worn (lower trend) and unworn (upper trend) regions of the cylinder (Rosén and others, 1997; Thomas, 1997). Inflection of structure function for unworn areas at $\tau \approx 20 \mu\text{m}$ corresponds to size of largest honing particles. Surface irregularities smaller than the $20 \mu\text{m}$ threshold are interpreted as being produced by a single continuous and almost ideally fractal process associated with fracture of the particles. The structure function, or variogram (Wald, 1989; Nikora and others, 1998), is a relief:distance plot, $S(\tau) = [z(x) - z(x+\tau)]^2$, where for a topographic profile $z(x)$, τ = horizontal separation of pairs of surface heights, z (Sayles and Thomas, 1977). Height data measured by an atomic-force microscope (AFM; vertical / horizontal resolution 3 picometers, pm/125 pm) and a conventional stylus instrument (vertical / horizontal resolution 20 nanometers, nm/5 micrometers, μm). TDC = top of piston travel; MID = halfway between top and bottom of piston travel.

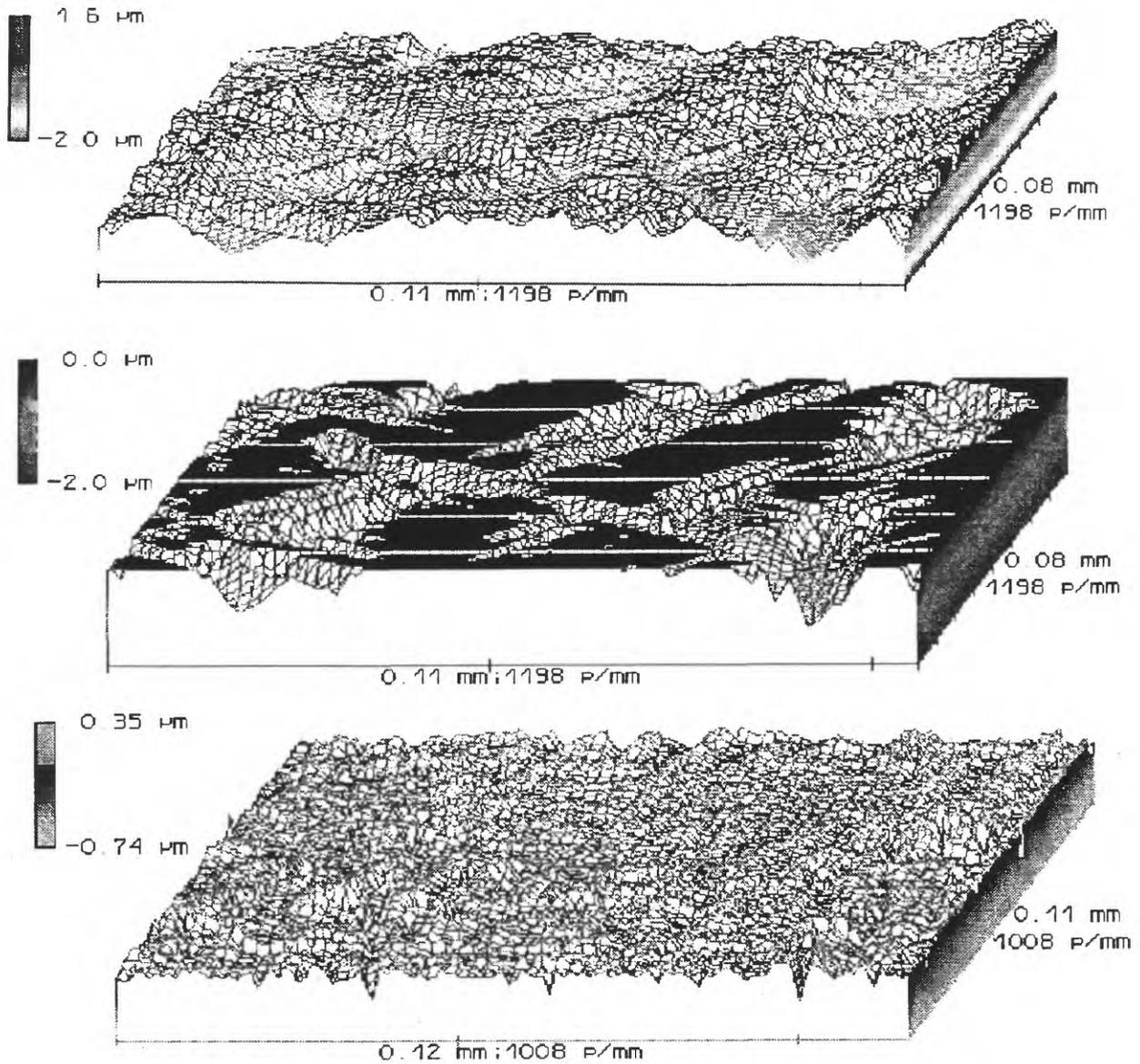


Figure 2. Example of 3-D visualization of surface-metrology height data. Wireframe plots are evidence of the need to reevaluate a prevailing hypothesis for the service performance of honed automotive cylinder bores (Rosén and others, 1996, p. 277-278). Heavy piston ring-to-bore wear expected in a cylinder's top dead center (TDC) section is simulated here (middle panel) by planar truncation of the original unworn surface (top panel), $0.49 \mu\text{m}$ below the original mean-height datum, to generate a plateau. The worn surface actually observed (bottom panel), however, does not fit this model. The diagram shows an irregular plateau with an entirely different and unexpected geometry, indicating plateau-wear interactions more complex than planar truncation by piston rings. Lower-resolution (1:10) measurements by conventional 2-D stylus-profiling did not reveal this critical difference. Height data measured every $0.48 \mu\text{m}$ (X, Y) by an atomic-force microscope (AFM; resolution 3 (Z) and 125 (X, Y) picometers, pm). Original figure in color.

Appendix I

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Appendix II

Selected 1996 Abstracts on Topographic and Fractal Topics in Surface Metrology

Alcock, Jeffrey, Sorensen, O. Toft, Jensen, Stig, Kjeldsteen, Per, 1996, **Comparative wear mapping techniques. II. Surface roughness and fractal dimension mapping of tungsten carbide/silicon carbide**: *Wear*, v. 194, no. 1-2, p. 228-237.

Pin surfaces were analysed by laser profilometry. Two roughness parameters, R/a and the fractal dimension, were investigated as a first step towards methods of quantitative wear mechanism mapping. Both parameters were analysed for their relationship to the severity and prevalence of a mechanism. Three-dimensional maps of R/a , fractal dimension, average slope and average inter-deviation spacing were produced. It was found that whilst mechanistic information for multiple mechanisms was contained within R/a and fractal dimension, without further quantitative knowledge of the surface, the influence of different mechanisms could not be separated. However, for a single mechanism, data on mechanism severity information could be obtained. This was shown to be the case experimentally for a microploughing mechanism, for both the microroughness R/a and the fractal dimension.

Almqvist, N., 1996, **Fractal analysis of scanning probe microscopy images**: *Surface Science*, v. 355, no. 1-3, p. 221-228.

The accuracy and precision of several algorithms, including newly developed, for calculating the fractal dimension from scanning probe microscopy images of material surfaces are investigated. The algorithm are based on the area-perimeter method, a variance method or versions of the structure function method. The latter two methods show good correspondence to computer simulated images, with known fractal dimensions, and have successfully been applied also on real images. The results show that these two methods give reliable fractal dimensions and are well suited to describe surface roughness quantitatively.

Amada, Shigeyasu, Yamada, Hiroshi, 1996, **Introduction of fractal dimension to adhesive strength evaluation of plasma-sprayed coatings**: *Surface & Coatings Technology*, v. 78, no. 1-3, p. 50-55.

The adhesive strength of ceramic coatings depends on the surface roughness of substrates. Taking account of the bonding mechanisms, however, surface roughness may not be a proper measure to evaluate the surface topography of substrates. Here, fractal dimension is proposed for the evaluation of surface topography. Physically the fractal dimension can include hook-shaped indentations which generate a mechanical interlocking force. By applying fractal dimension to the evaluation of the surface topography of substrates and relating it to the adhesive strength of alumina coatings, it

was concluded that fractal dimension properly evaluates the adhesive strength as compared with surface roughness.

Avanesov, V.S., Zuev, M.A., 1996, **Investigation of surface topography after melting by laser beam**: *Proceedings of SPIE - The International Society for Optical Engineering*, v. 2713, Bellingham, WA, p. 340-343.

Experimental and theoretical investigations of surface microrelief of steels with various carbon contents were carried out after melting by continuous carbon-dioxide-laser radiation. The model advanced to describe the microrelief formation has shown the coincidence with experimental data. Some technical measures for decreasing the roughness after laser melting by moving beam were pointed out.

Bhushan, Bharat, 1996, **Nanotribology and nanomechanics of MEMS devices**:

Proceedings of the IEEE Micro Electro Mechanical Systems (MEMS), IEEE, 96CH35856, p. 91-98.

MEMS devices are made of single-crystal silicon, LPCVD polysilicon films and other ceramic films. Very little is understood about tribology and mechanical characterization of these materials on micro- to nanoscales. Atomic force microscopy/friction force microscopy (AFM/FFM) techniques are increasingly used for tribological studies of engineering surfaces at scales, ranging from atomic and molecular to microscales. These techniques have been used to study surface roughness, adhesion, friction, scratching/wear, indentation, and boundary lubrication of bulk and treated silicon. Commonly measured roughness parameters are found to be scale dependent, requiring the need of scale-independent fractal parameters to characterize surface roughness. Measurements of micro-scale friction and macroscale friction show that friction values both on micro- and macroscales of all samples are about the same. The microscale values are lower than the macrovalues as there is less ploughing contribution in microscale measurements. Local variation in microscale friction is found to correspond to the local slope. Directionality in the friction is observed on microscale which results from the surface preparation and anisotropy in surface roughness. Microscratching/microwear and nanoindentation studies indicate that coated/treated silicon is superior to bare silicon. Chemically bonded lubricants appear to be suitable for MEMS devices. Finally, ultrasMOOTH surfaces under extremely lightly loaded conditions are required for ultralow friction and near-zero wear.

Bozhevolnyi, Sergey I., Vohnsen, Brian, Zayats, Anatoly V., Smolyaninov, Igor I., 1996, **Fractal surface characterization—implications for plasmon**

polariton scattering: Surface Science, v. 356, no. 1-3, p. 268-274.

We compare the scattering of surface plasmon polaritons (SPPs) at relatively smooth and rough surfaces of gold films and relate the difference in the SPP behaviour to the difference in fractality of the studied surfaces. The rough surface, which results in the strong localization of SPPs, is found to have a fractal structure with a normalized fractal dimension D approximately equals 2.26 in the spatial range 80-640 nm. It is shown that the smooth surface, which supports well-pronounced propagating SPPs, cannot be viewed as a fractal structure for discretization steps exceeding 80 nm. We conclude that in order for SPPs to be localized by surface roughness, the surface should exhibit a fractal structure in a sufficiently large range of sizes around the SPP wavelength.

Cerre, N., de Fornel, F., Goudonnet, J.P., Ladan, P.R., Guerrin, Ph., 1996, **Spatial spectroscopy with the reflection scanning microscope:** Journal of the Optical Society of America - A, v. 13, no. 7, p. 1357-1361.

Spatial spectroscopy effected with reflection scanning microscope (RSM) by modulating the fiber-sample distance is shown to give more information that is not contained in topographic images obtained with RSM in a constant-intensity mode. When the sample is homogeneous, the spectroscopic image shows the variation of reflectivity that is due to the roughness of the surface. These images, in correlation with the topographic ones, should lead to a better description of the samples. For the homogeneous sample studied, a comparison of the topographic and spatial spectroscopic images allows one to know whether the fiber is close enough to the sample, i.e., the fiber is in a proper operating zone. For an inhomogeneous sample with a certain roughness the analysis of the images is more complicated. To deconvolute these two sources of information, one can vary the wavelength to produce a map of the different materials present on the surface.

Christiansen, S., De Chiffre, L., 1996, **Topographic investigation of the wear resistance of PTFE seals in sliding contact with ceramic materials:** Tribology Transactions, v. 39, no. 2, p. 434-440.

This paper is concerned with the wear of PTFE seals used in connection with reciprocating ceramic-coated rods. An analysis of the relationship between the surface topography of ceramics and wear of PTFE seals was undertaken, formulating three hypotheses which have been investigated experimentally using a seal test rig and a system for three-dimensional surface roughness analysis. It was observed that no running-in of the rod surface takes place and, consequently, the tribological situation never stabilizes. It was shown that seal wear rate is dependent on the number of asperities penetrating the lubricant film thickness, the wear rate being correlated to a functional parameter $(S//p//k// //o)$ which was especially developed to describe the peak height above the mean plane. Furthermore, it was illustrated how the structure of ceramics allows the lubricant to flow unhindered between isolated asperities

in contrast to the traditionally polished structure of steel which restricts the lubricant flow.

Dove, J.E., Frost, J.D., Dove, P.M., 1996, **Geomembrane microtopography by atomic force microscopy:** Geosynthetics International, v. 3, no. 2, p. 227-245.

The use of surface roughness measurements for evaluating and predicting the performance of composite geosynthetic structures has become of interest to the civil engineering profession, especially those involved in the design of landfills. This paper introduces a recently developed method, tapping mode atomic force microscopy, for measuring smooth high density polyethylene geomembrane microtopography. The surface morphology and the degree of surface roughness are examined at a scale comparable to fine-grained soil particles used in composite landfill liners. The results show that within a $10 \mu\text{m}^2$ scan area, asperity relief ranges from approximately 0.46 to $2.4 \mu\text{m}$. Surface roughness is quantified using mean roughness, root mean square roughness, surface roughness parameter, and fractal dimension.

Eisenbarth, E., Meyle, J., Nachtigall, W., Brems, J., 1996, **Influence of the surface structure of titanium materials on the adhesion of fibroblasts:** Biomaterials, v. 17, no. 14, p. 1399-1403.

Of utmost importance for the successful use of an implant is a good adhesion of the surrounding tissue to the biomaterial. In addition to the surface composition of the implant, the surface topography also influences the properties of the adherent cells. The aim of this investigation was thus to study the influence of the surface structure of the substrate on the formation of focal contacts and on the orientation of cultivated gingival fibroblasts by means of fluorescence microscopy. A further goal was to determine the effect of the material composition on the cell shape, on the assumption that in each case a lengthening of the cells can be expected to provide a more favourable adhesion behaviour than a spherical cell shape. In order to describe the shape of the cell, a shape factor was defined which was calculated from the area covered by the cells and from their circumference. To determine the influence of the surface structure, substrate platelets of cp-titanium, TiAl6V4 and TiTa30 were ground. Onto these specimens human gingival fibroblasts of the 5th to 7th passages were cultivated. After a culture time of two days the cells were fixed and stained. The number of orientated cells was determined as a function of the surface roughness of the substrate. The number of orientated cells was shown to increase - independent of the material - with increasing roughness of the ground substrate. On a polished surface the number of orientated cells was 11% (average peak-to-valley height $0.04 \mu\text{m}$), at a peak-to-valley height of $1.36 \mu\text{m}$ the number of orientated cells increased to 72%. It could be observed that the orientated cells had a higher density of focal contacts where they were in contact with the edges of the grinding grooves. In order to determine the effect of the surface composition, gingival fibroblasts were cultured for 14d on polished substrate specimens of cp-

titanium, TiAl6V4 and TiTa30 and examined for differences in shape. The cells grown on cp- titanium and on TiTa30 had shape factors of 1.76 and 1.58 respectively, whereas those grown on TiAl6V4 had a shape factor of 0.93. The unfavourable spherical shape of the fibroblasts (resulting in a poor adhesion) grown on TiAl6V4 after a culture period of 14d may be the result of a locally increased vanadium concentration in the substrate, with an accompanying increase in the release of toxic vanadium ions.

Forseth, T., Helle, T., 1996, **Principles and application of a method for assessing detailed paper surface topography**: Annual Meeting - Technical Section, Canadian Pulp and Paper Association, Preprints, Pt. B, Montreal, Que., p. B287-B291.

A method for detailed paper surface topography assessment is presented which uses a mechanical stylus profilometer. A device controls it to perform parallel scans at intervals of some 2.5 μm . The instrument is attached to a computer which collects and transfers the recorded information into topographical maps and other numerical representations of height distribution. The instrument is also equipped with a microscope and a videoprinter, allowing the paper samples to be accurately repositioned in the profiling instrument, allowing the exact same area to be compared before and after the treatment. In this paper, experimental methods and analysis procedures are explained, and results are presented from a study on calendered commercial paper, containing mechanical pulp fibers, before and after moistening.

Gjonnes, Liv, 1996, **Development of surface topography during cold rolling of twin-roll cast aluminum**: Wear, v. 192, no. 1-2, p. 216-227.

A study of the development of surface structure during cold rolling of twin-roll cast aluminum has been carried out owing to its importance for appearance, forming properties and corrosion resistance. It is found that the as-cast surface determines the development of the surface topography during cold rolling. This is due to the large roughness associated with the groove/shingle configuration of the as-cast surface. During the first rolling pass the large grooves are deformed into gorges with flat areas between. Peaks are smeared opposite to the rolling direction forming shingles in the subsequent passes. These shingles do not completely adhere to the underlying bulk material and consequently deform heterogeneously on further rolling. Cross hatches may develop on the surface of the shingles. The cross hatches increase in size and spacing on successive rolling, and new ones are formed. Varying amounts of aluminum fines were found in the lubricant as the ends of the shingle are detached from the surface during deformation. The final rolled surface is characterized by thin shingles which overlap and make regions of lamellae in a narrow thickness range on the surface. Many cross hatches of varying size and distribution penetrate one or several of these lamellae.

Gollion, Ph., Grenet, G., 1996, **Determination of fractured steel surface roughness by**

atomic force microscopy using fractal-based approaches: Surface and Interface Analysis, v. 24, no. 4, p. 282-285.

Roughness images of fractured steel were recorded at micrometric level (100-10 000 nm) using an atomic force microscope. We have observed a power law variation of the profile root-mean-square vs. the analysis length. If there is no overall tilt of the images, this variation is indicative of the (self-affine) fractal character of the surface morphology. Using first-principle methods, the fractal dimension of the studied fractured steel surfaces is found to be D equals 1.13 plus or minus 0.06 at the micrometre scale and thus of the same order as previously published values obtained at the centimetre and millimetre scales.

Heyvaert, I., Krim, J., Van Haesendonck, C., Bruynseraede, Y., 1996, **Surface morphology and kinetic roughening of Ag on Ag(111) studied with scanning tunneling microscopy**: Physical Review E, v. 54, no. 1, p. 349-353.

The scanning tunneling microscope has been used to study the topography and the evolution of the surface roughness during the growth of Ag on Ag(111). The surface roughness and the scaling exponents are compared to exponents obtained from growth models in order to reveal the underlying growth mechanism. For thicknesses below 250 angstrom, the growth is found to proceed via 3D island growth. For thicker layers, the surface becomes irregular. Roughness exponents close to 1 have been obtained, in agreement with other experimental results as well as with the theoretical models.

Hull, D., 1996, **Influence of stress intensity and crack speed on fracture surface topography—mirror to mist transition**: Journal of Materials Science, v. 31, no. 7, p. 1829-1841.

The transition from very smooth 'mirror' crack growth to the early stages of roughening associated with 'mist' has been investigated using a range of surface topography techniques. The fracture mechanics properties of the brittle, glassy and isotropic epoxy resin have been characterized using compact tension (CT) and double torsion (DT) tests. In general, the results provide an insight into the development of crack instabilities under dynamic conditions and a basis for interpreting the progressive development of roughness up to macroscopic bifurcation.

Lee, Si C., Ren, Ning, 1996, **Behavior of elastic-plastic rough surface contacts as affected by surface topography, load, and material hardness**: Tribology Transactions, v. 39, no. 1, p. 67-74.

Surface roughness plays an important role in affecting friction, wear, and lubrication of contacting bodies. A small change in the distribution of the asperity heights and widths can have a significant effect on the performance variables which include the real area of contact, the average gap, and the average asperity contact pressure. A series of contact simulations were

conducted in order to investigate the effects of the surface topography, material hardness and load on the deformation behavior of the rough surfaces. These surfaces were numerically generated by computer and varied widely in statistical roughness properties, ranging from isotropic to strongly anisotropic. The current simulations took into account the elastic-plastic deformation behavior of the asperities. Using the contact simulation results, the performance variables were curve-fitted to convenient analytical formulas as functions of the surface roughness parameters, material hardness, and load.

Lopes, M.C.V., dos Santos, S.G., Hasenack, C.M., Baranauskas, V., 1996, **Si-SiO₂ electronic interface roughness as a consequence of Si-SiO₂ topographic interface roughness**: Journal of the Electrochemical Society, v. 143, no. 3, p. 1021-1025.

Numerical calculations were used to assess the probable microscopic distribution of the electric field along or close to the actual Si-SiO₂ interface of a metal oxide semiconductor (MOS) capacitor biased into accumulation. Silicon wafers were oxidized to 20 nm at 1150 degree C by rapid thermal oxidation, according to two different thermal recipes in order to yield different Si-SiO₂ interface roughnesses. After oxide removal, typical atomic force microscopy (AFM) line scans of the silicon surface were exported into the MEDICI program as a description of the Si-SiO₂ interface in order to calculate the electric field distribution within the oxide layer of a bidimensional MOS capacitor biased into accumulation. This distribution was found to be highly inhomogeneous even for relatively smooth Si-SiO₂ interfaces, displaying strong local electric field enhancements, the spatial distribution of which will be called electronic roughness in this work. Simple local oxide thinning at the position of the protrusions cannot account for these field enhancements, thus indicating that the shape of the protrusion is dictating the electronic roughness. The electronic roughness could be correlated with electric breakdown characteristics of actual MOS capacitors prepared on these wafers.

Miyazima, Sasuke, Matsuura, Shu, 1996, **Morphology of the fungus aspergillus oryzae and nidulans**: Disordered Materials and Interfaces, Materials Research Society Symposium, Pittsburgh, PA, Proceedings, v. 407, p. 301-306.

A variety of growth manner of the fungus *Aspergillus oryzae* and *nidulans* under varying environmental conditions such as the nutrient concentration, and medium stiffness are investigated, ranging from a homogeneous Eden-like to a ramified DLA-like pattern. The roughness sigma (l, h) of the growth front of the band-shaped colony, where h is the mean front height within l of the horizontal range, satisfies the self-affine fractal relation under favorable environmental conditions.

Ohlsson, Robert, 1996, **A topographic study of functional surfaces**: Göteborg, Sweden, Department of Production Engineering, Chalmers

University of Technology, unpublished Ph.D. thesis, paging unknown.

Surface topography through the years has taken on increased importance, because of the rise in quality demands. The surface often has to meet additional functional demands when products become more complex in accordance with customer preferences. This poses great demands on the manufacturing process to produce the characteristics needed for optimal function. This makes the field of surface topography not only interesting but necessary, since erroneous specifications can be very costly and result in a nonfunctional surface. This thesis is a contribution to the area of surface topography. The results are presented in eight separate but related papers concerning how to measure and characterise the topography on functional surfaces enabling control of the manufacturing in order to ensure that the desired surface properties are obtained. The results presented are relevant for many engineering surfaces even though mainly one of them has been used in this work: the surface of the cylinder liner in motor vehicle engines. When manufacturing such a surface, knowledge about the interdependence between functional demands, characterisation, and manufacturing of the surface is essential. A PC-based knowledge system, Interactive Surface Modelling (ISM), has been developed, making a structured storage of the surface-related information possible. The concept used in ISM is to divide the functional surfaces into separate functional requirements and connect these with proper design parameters, process variables, and measuring strategies. The system also comprises databases with standards and reference literature making it a useful support in the manufacturing of surfaces. A great amount of effort has been made in order to use 3D surface roughness measuring and evaluation, since it opens up a whole range of possibilities to understand the surface from its functional aspect. Advantages of 3D measurements and peculiarities involved in this technique are discussed together with methods for optimising the measuring strategy. Two different types of instruments for these measurements have been evaluated: stylus and focus detection. An Atomic Force Microscope (AFM) has been used here as a reference instrument to give a quantitative judgement of the deviation between the two instruments. The wear process in the cylinder liner has been studied by measuring unworn and worn surfaces using effective relocation and replication techniques. The AFM was used and was found to be a necessary complement to ordinary stylus instruments for a proper characterisation of the wear process. The new 3D topography information accessible by the AFM made it possible to verify that the plasticity index could be used for the prediction of wear, requiring only the measuring of slopes in the surface. The cylinder liner surface also was found to have a fractal behaviour over more than three orders of magnitude in sampling distance.

Pawelski, Hartmut, 1996, **Applicability of fractal concepts to surface roughness**: Steel Research, v. 67, no. 4, p. 144-148.

The stochastic part of metal surface profiles can be described by means of fractal geometry. The scaling behaviour of the roughness-depth as function of the basis length is related to the non-integral fractal dimension. Regular fractals, which are constructed similarly to the Koch-curve, are not capable of reproducing typical roughness-depth distributions. More adequate is the Weierstrass-Mandelbrot function. If the bearing area ratio approximately follows a power law, the parameters can be easily determined from the exponent and the form of the roughness-depth distribution, as is shown for a technical surface after cold-rolling. If the Weierstrass-Mandelbrot function is used in two classical friction models, the influence of the parameters including the fractal dimension on the friction coefficient in the case of dry surfaces can qualitatively be estimated.

Pawlus, P., 1996, **Study of the dependence of the functional properties of the cylinder liner surface layer on the operating conditions**: Proceedings of the Institution of Mechanical Engineers, Part J: Journal of Engineering Tribology, v. 210, no. 1, p. 17-27.

The paper presents results of the measurements of the surface roughness and physical properties of the outer layer of honed cylinders. The results of wear measurement of the cylinders and piston rings mating with them during running-in and during automotive engine operation under artificially increased dustiness conditions are presented and analysed.

Interdependences among the state of the cylinder liner outer layer and operating parameters of the engines after running-in are also analysed. Additionally, the honed cylinder liners were used as specimens in wear resistance tests performed in the presence of lubricating oil with some amount of grinding particles. The results of the measurements of specimen and counter-specimen wear, as well as friction force and temperature at the friction surfaces during the test, are also presented and analysed. It was found that abrasive wear resistance of the honed cylinder liner depends on the operating conditions. During engine operation under increased dustiness conditions cylinder wear intensity depends mainly on the initial surface topography. Under conditions of low relative speed, low temperature and constant load, cylinder wear resistance in the case of large wear values depends on physical properties of the surface layer. However, when the amount of wear is smaller than the initial surface height, cylinder wear intensity in two studied cases depends mainly on its surface topography.

Press, W., Tolan, M., Stettner, J., Seeck, O.H., Schlomka, J.P., Nitz, V., Schwalowsky, L., Mueller-Buschbaum, P., and Bahr, D., 1996, **Roughness of surfaces and interfaces**: Physica B, v. 221, no. 1-4, p. 1-9.

X-ray reflectivity is now a common tool for investigating density profiles of thin films and multilayers in a nondestructive manner. In contrast to the specularly reflected beam the nonspecular diffuse intensity is sensitive to the lateral structure of rough interfaces. The most reliable results are obtained from simultaneous fits of all available data (i.e. reflectivity together with all

diffuse scans) with a single set of parameters. It turns out that diffuse scattering experiments from a large class of systems can be described by correlation functions of self-affine fractal surfaces. Two layer systems serve as test cases: (1) A CoSi₂/Si-layer system grown by molecular beam epitaxy (MBE) and (2) Langmuir-Blodgett films. The analysis within the distorted-wave Born approximation (DWBA) of the scattering from the silicide sample gives a large amount of information, e.g. strong vertical correlations. For the topmost surface a comparison between scanning tunneling microscopy (STM) and X-ray results leads to very good agreement. Nine and eleven monolayer Langmuir-Blodgett films with high defect concentrations also can be successfully analyzed with the fractal model. The lateral lengths obtained from the diffuse scattering and grazing-incidence diffraction (GID) agree.

Provdor, Theodore, Kunz, Barbara, 1996, **Application of profilometry and fractal analysis to the characterization of coatings surface roughness**: Progress in Organic Coatings, v. 27, no. 1-4, p. 219-226.

Quantitation of the analysis of coatings surface roughness by a contact profilometer was undertaken to obtain improved repeatability and meaningfulness of data. This effort involved interfacing the profilometer to a personal computer for data acquisition and analysis, optimizing operational variables involved in the measurement process and improving methods for quantitative data analysis of the roughness profiles. The quantitative methods of data analysis explored included the use of various surface profile roughness averages, power spectrum analysis through zone integrals, auto-correlation function analysis and fractal analysis of the surface roughness profile. Quantitative parameters obtained from the above methods were correlated with visual and optical methods for evaluating appearance for a variety of coatings. The superiority of correlation with evaluations of appearance and repeatability of multiple runs will be demonstrated for fractal numbers obtained from a fractal analysis of surface roughness profiles.

Rappich, J., Lewerenz, H.J., 1996, **Photo- and potential-controlled nanoporous silicon formation on n-Si(111)—an in-situ FTIR investigation**: Thin Solid Films, v. 276, no. 1-2, p. 25-28.

The microtopography of n-Si (111) in acidic fluoride-containing solution is strongly influenced by the electrode potential under illumination. The surface condition changes between flat, rough and porous, respectively. The thickness of the hydrogen-terminated porous silicon layer depends on the photocurrent density and reaches a saturation value, where the porosity is preserved. The surface roughness and porosity during the photoelectrochemical etching process was investigated by in-situ Fourier transform infrared spectroscopy using multiple internal reflection techniques due to the low IR absorption of the Si-H stretching mode. Additional single internal reflection measurements show no formation of silicon oxide during the light-assisted corrosion reaction. The surface topography was inspected ex situ by field emission

scanning electron microscopy with a resolution of about 2 nm.

Razafitrimo, H., Gao, Y., Feld, W.A., Hsieh, B.R., 1996, **Layer-wise topographic study of a polymeric light-emitting diode—Indium-tin oxide/poly(2,3-diphenyl-p-phenylene vinylene)/Ag**: *Synthetic Metals*, v. 79, no. 2, p. 103-106.

Scanning tunneling microscopy was used to characterize surface topographies relevant to polymeric light-emitting diodes (LEDs) whose active medium is a thin film of poly (2,3-diphenyl-p-phenylene vinylene) (DP-PPV). We performed a sequence of topographic studies on an indium-tin oxide (ITO) substrate, a DP-PPV film deposited on the ITO substrate, and a Ag layer of thickness of about 100 angstroms as evaporated on the DP-PPV film. ITO showed a granular structure, DP-PPV exhibited a fibrous-like bundled structure, and the Ag layer formed clusters whose surface roughness was comparable to the layer thickness. The different surface topographies were quantified by using the scaling of the height-height correlation functions. 15 Refs.

Roberds, Brian E., Farrens, Shari N., 1996, **Atomic force microscopy study on the roughness of silicon wafers correlated with direct wafer bonding**: *Journal of the Electrochemical Society*, v. 143, no. 7, p. 2365-2371.

Atomic force microscopy has been used to quantitatively determine the surface roughness of silicon substrates as a function of processing and limitations to direct wafer bonding ability. This data is conveniently converted into a power spectrum creating a description of the topography which contains information about the amplitude and frequency of the surface undulations. Following initial characterization, the wafers were subjected to typical device manufacturing processes resulting in various degrees of increased roughness. An empirical correlation was developed between the roughness spectrum and bondability of (100) silicon wafers. Data on the roughening of wafers due to various standard integrated circuit processing steps were obtained and used to identify processes which promote wafer-to-wafer direct bonding. The fractal dimensions of the surfaces have been calculated and are discussed.

Rosèn, B.-G., Ohlsson, Robert, and Thomas, T.R., 1996, **Wear of cylinder bore microtopography**: *Wear*, v. 198, no. 1-2, p. 271-279.

Atomic force microscopy (AFM) reveals additional 3D topography information on tribology surfaces previously measured and evaluated by conventional 2D stylus technologies. This paper deals with the implications of the more detailed topographical information scanned from cast iron automotive cylinder liners. Worn and unworn surfaces measured both by AFM and stylus techniques were compared visually and quantitatively using an effective relocation technique. Quantitative comparison was made of 3D and 2D surface parameters, such as root mean square roughness, and slope, significant for the tribological behaviour of the surfaces. The extra surface features found by the AFM measurements (e.g. steeper slopes and more peaks and

valleys) significantly change the numerical values of the roughness parameters, and this scale-dependent difference, when compared with conventional stylus-measured parameters, points to the possibilities of deepening the understanding of cylinder liner lubrication in the light of more finely detailed measurements.

Sheppard, C.J.R., 1996, **Scattering by fractal surfaces with an outer scale**: *Optics Communications*, v. 122, no. 4-6, p. 178-188.

Scattering by surfaces with the correlation function given by a modified Bessel function of the second kind, including the special case of exponential correlation, is considered. These surfaces behave as fractals with an outer scale. The treatment is based on the introduction of normalized spatial frequencies in both the transverse and axial directions, which shows clearly the scaling properties of the parameters. The bidirectional reflectance distribution function is given, and the limiting cases of smooth and rough surfaces are discussed. In particular, analytic expressions are given for scattering by rough surfaces.

Simao, J., Aspinwall, D.K., Wise, M.L.H., Subari, K., 1996, **Surface texture transfer in simulated tandem and temper mill rolling using electrical discharge textured rolls**: *Journal of Materials Processing Technology*, v. 56, no. 1-4, p. 177-189.

The surface texture of cold reduced steel sheet of the type used for automotive applications plays an important role during subsequent processing operations. The paper outlines the results of an extensive series of electrical discharge texturing (EDT) experiments aimed at evaluating the effect of workpiece rotational speed and flushing method on roll texture parameters, specifically surface roughness (Ra) and peak count (Pc), in both the axial and circumferential directions. The EDT rig comprised a DC servo quill assembly fitted with a single graphite electrode connected to a dual voltage pulse generator. In addition results are presented from a 'tandem mill' simulation which gives texture transfer parameters from the EDT roll to the sheet steel (CSI) for a 3% reduction. High speed steel rolls (M2) were used in a four high Stanat Mann mill. Finally the effects of overlaying a second 'temper roll' texture on the sheet steel are detailed for reductions of 0.5, 1.0 and 1.5%. Scanning electron micrographs are included of the various textured surfaces together with some 3-D topographical representations.

Thompson, C.B., McDonald, J.D., Pikulik, I.I., 1996, **Characterization of press roll topography**: *Annual Meeting - Technical Section, Canadian Pulp and Paper Association, Preprints, Pt. B 1996*, Montreal, Que, p. B101-B110.

Surface profilometry data have been collected for a range of established and experimental press roll materials, including granite. None of the height or shape parameters derived from the data were able to clearly distinguish between granite and the other materials, either in terms of surface texture or surface functionality. The autocorrelation function gave the best correlation with sheet release, the fractal dimension was

the only other parameter that showed any trend with release. Although surface roughness was not able to characterize press roll release, the ratio of root mean square roughness to average roughness appears to be a convenient qualitative way of measuring the surface texture of granites as they wear. Press roll surface texture involves contributions from long-range waviness, macro-texture and micro-texture. Macro-texture appears to be important for the behaviour of water films in the nip.

Vallejo, Luis E., 1996, **Evaluating the variability of engineering properties of soil deposits using fractals**: Geotechnical Special Publication, no. 58/1 1996. ASCE, New York, p. 353-367.

Soil deposits are non-homogeneous. This non-homogeneity of soil deposits is reflected in the irregular distribution with respect to depth of many of their engineering properties. In general the more non-homogeneous are soils in the field, the more irregular is this distribution. An assessment of the degree or extent of variability of the engineering properties in soil deposits is usually made from a visual inspection of the plots of the properties versus depth. The present study presents a quantitative method to measure the level of variability with respect to depth of the engineering properties of soil deposits. The method used relies on the concept of fractal dimension from fractal theory. The fractal dimension measures the geometry of irregular profiles using a fractional number that varies between 1 and 2. The fractal dimension value is equal to 1 for smooth, straight line profiles. For rough profiles, the fractal dimension approaches a value of 2. Profiles representing the distribution with depth of the normalized permeability coefficient ratio, natural water content, unconfined compressive strength, angle of shearing resistance, and standard penetration resistance for various soil deposits were evaluated. The fractal dimension for the profiles varied in value between 1.1736 and 1.5851. In general, it was determined that high fractal dimension values were associated with plots of engineering properties versus depth that were rough or highly variable. The fractal dimension concept proved to be a powerful and simple mathematical tool to measure the irregularity of the distribution with respect to depth of the engineering properties in soil deposits.

Vazquez, L., Salvarezza, R.C., Herrasti, P., Ocon, P., Vara, J.M., Arvia, A.J., 1996, **Scale-dependent roughening kinetics in vapor deposited gold**: Surface Science, v. 345, no. 1-2, p. 17-26.

The roughening kinetics of gold deposits grown from vapor was studied by scanning tunneling microscopy. The dynamic scaling yielded the following growth exponents α (I) equals 0.90 plus or minus 0.06 and β (I) equals 0.25 plus or minus 0.06 for L/s less than d/s , and α (II) equals 0.37 plus or minus 0.05 and β (II) equals 0.45 plus or minus 0.06 for L/s greater than d/s , where L/s is the scan length and d/s is the average diameter of columns. The scaling properties of the domain-dependent-surface roughness exponents allowed us to give the rationale for experimental data on the fractal behavior of thin metal films.

Wennerberg, Ann, 1996, **On surface roughness and implant incorporation**: Ph.D. thesis, Dept. of Biomaterials, Inst. for Surgical Sciences, Univ. Göteborg, Sweden.

Purpose: The aim of the present work was threefold:

1. To develop a method for non-destructive surface roughness characterisation of implants. The method had to be suitable for use with a range of implant designs and materials.
2. To investigate experimentally the influence of surface roughness on bone formation around implants and, thereby establish if there is an optimal range of surface roughness.
3. To investigate the application of a topographical measuring technique for use with clinical material in implant research.

Materials and Methods: A confocal laser surface scanning microscope designed for topographical characterisation, was tested and adapted to enable measurements of different implant types including screw-shaped designs. Comparisons were made with a contact stylus profilometer and an atomic force microscope with the aim of ensuring the accuracy and reliability of the optical confocal laser profilometer. A series of six studies was undertaken. 318 threaded implants with a diameter of 3.7 mm, length 6 to 7 mm and a pitch-height of 0.6 mm were inserted in 56 New Zealand white rabbits. Implants of varying surface roughness were produced by a blasting procedure using 25, 75, and 250 μm sized particles of Al_2O_3 and 25 μm particles of TiO_2 . As-machined, (i.e. turned) implants served as controls. The implant surface roughness was measured with the confocal laser scanner (TopScan 3D). After different implantation times, the animals were euthanised. The implants were evaluated with respect to the peak removal torque, the percentage of bone-to-implant contact and the percentage of bone inside the threads. Two studies utilised clinical oral and orthopaedic implants.

Results: The TopScan 3D was found to be suitable for surface topographical characterisation of different designs of implants. The results from the animal experiments demonstrated, generally, higher removal torques and higher percentages of bone-to-implant contact for implants blasted with 25 and 75 μm sized blasting particles than with as-turned or 250 μm blasted implants. The corresponding average roughness for the 4 surfaces was 1 μm , 1.5 μm , 0.6 μm , and 2.1 μm . When comparing the 25 and the 75 μm blasted implants it was found that 75 μm blasted screws showed the stronger bone fixation. The investigation of clinical oral implants demonstrated considerable variation with respect to the surface topography. This was true not only for implants manufactured with different surface modifications but also for implants produced by comparable methods and to comparable optical finishes. The retrieved orthopaedic implants demonstrated no correlation between surface roughness and, a number of factors including implant loading time.

Conclusions: The TopScan 3D system was shown to be a suitable measuring instrument for implants intended for experimental purposes as well as for clinical applications. Furthermore, implants prepared with a surface structure without a dominating pattern, and with an average surface roughness of about 1.5 μm , an average wavelength of about 11.1 μm and a developed

area ratio of 1.5 were found to have the firmest bone fixation among the investigated surface structures.

Wennerberg, Ann, Albrektsson, Tomas, and Lausmaa, Jukka, 1996, **Torque and histomorphometric evaluation of c.p. titanium screws blasted with 25- and 75- μm -sized particles of Al//2O//3**: Journal of Biomedical Materials Research, v. 30, no. 2, p. 251-260.

A comparison was made between screw-shaped c. p. titanium implants blasted with either 25- or 75- μm particles of Al//2O//3. The implant surfaces were investigated with respect to topography and composition before implantation in rabbit bone. Grit blasting with 25- or 75- μm particles produced two different surface roughnesses, but no significant difference in the surface composition for the two surfaces. After 12 weeks insertion time in the rabbit tibia and femur, a higher

removal torque and more bone-to-metal contact was found for the implants blasted with 75- μm particles compared with the 25- μm -blasted ones.

Yamauchi, Tatsuo, Kishimoto, Shuji, 1996, **Application of vertical scanning interferometric profiler to paper surface**: Paperi ja Puu/Paper and Timber, v. 78, no. 1-2, p. 29-31.

A new type of surface profiler known as a vertical scanning interferometric profiler was evaluated using coating base paper and the respective coated papers before and after supercalendering. Accuracy of the profiler was checked by comparing the curves obtained. The results showed that the profiler is an excellent tool for investigating the surface topography of paper materials on both macroscopic and microscopic scales.

Internet Access to Surface Metrology

The presence of industrial surface topography on the World Wide Web is limited and does not yet compare with that of terrain modeling in the Earth sciences (Pike, 1998). Metrology Web sites tend to focus on instrumentation and commercial services rather than on topographic analysis *per se*. A brief introduction may be gained from a French firm, Digital Surf, at <http://www.digitalsurf.fr/>, which describes its commercial software for 2-D and 3-D analysis as well as industrial applications to cosmetics, automobiles, and iron and sheet-steel. An excellent introduction to manufacturing standards from ISO may be consulted at <http://www.iso.ch/infoe/intro.html>. Very brief, but informative primers are available for surface texture (<http://www.mech.port.ac.uk/Info-by-Dept/Manf-and-Mgt/metrology/surface.html>) and *asperities*, micro-surface hill- and ridge-tops (<http://www.msm.cam.ac.uk/tribo/asperity.htm>).

The Production Engineering Department at Chalmers University in Sweden has a Web site, at <http://www.pe.chalmers.se/home.html>, that describes work on automobile engine cylinder-liners, sheet metal, and geared-wheel surfaces. A detailed analysis of metal-surface patterns milled by abrasive water-jet technology is illustrated at

<http://www.itek.chalmers.se/homepage/mop6cif/exp54.htm>. A 1996 article in the quality-control magazine *Quality*, on the role of scanned-probe microscopes in the study of surfaces of automotive coatings and finishes, auto bumper materials, and magnetic-recording heads is at <http://www.qualitymag.com/1096f3.html>. Another 1996 *Quality* article describes the role of digital filters in measuring surface roughness (<http://www.qualitymag.com/03q1.html>).

TopoMetrix, a major manufacturer of scanning-probe microscopes, has a good Web site at <http://www.topometrix.com/>. An introduction to the atomic force microscope by Advanced Surface Microscopy, Inc. (Indianapolis) and several applications are well illustrated at <http://www.a1.com/asm/index.html>. A general introduction to nano-surface processes in the fabrication of silicon wafers for the microelectronics industry, from Uppsala University, is at <http://www.mises.teknikum.uu.se/ilia/gen.htm>. Activities of the Precision Engineering Center at Huddersfield University, UK, where Prof. K.J. Stout (an authority on surface topography) became Dean of Engineering in 1997, may be followed at <http://www.hud.ac.uk/schools/engineering/research/ultrap/preceng.htm>. A series of IDL-based computer routines written by David Windt at Bell Laboratories for analyzing 2-D and 3-D surface-roughness data are available free at <http://www.bell-labs.com/project/topo/>.
